Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/810,262	NAYLOR ET AL.	
Examiner	Art Unit	
Shin-Lin Chen	1632	

	SEAR	CHED	
Class	Subclass	Date	Examiner
514	44		
435	320.1		
435	455		
424	93.21		
536	23.5		
536	24.1	6/14/2006	Gu

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
			

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
STN, WEST, Medline, Caplus, Biosis, Scisearch, Lifesci, Parents reviewed and updated.	6/14/2006	Gre
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